

# **Product Qualification Report**

To: Those who may concern

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Date: Oct 25, 2022 -Rev 1

Subject: Qualification Test Result for Semicon Champion TVS TPSMC Product Series

## Purpose:

This report is to inform the successful AEC-Q101 qualification test results associated with TVS TPSMC Product Series.

### 1. Qualification Types (Test Vehicle)

Product Series	Representative Test Sample Part Numbers	Package(Assembly Location)	
TPSMC	TPSMC56A	ShangHai Jinke Semiconductor Equipment Co., LTD	

## 2. Qualification Test Items and Result Summary:

Test Category	Description	Sample P/N	Sample Qty	Test Ref#	Contents/Conditions	Result Summary
Parametric	Electrical Parameters	TPSMC56A	370	Datasheet	VBR、IR	100% meet published spec.
Surge IPP test	10X1000us Surge Out	TPSMC56A	5	Datasheet	+/- 1 hit, from rated IPP, 0.1 IPP step	100% passing at 1.2xRated IPP



<b>X</b> = - 7					1	
Reliability Test Hig Rev Hig Rev Hig Rev So	Pre-condition (PC)	TPSMC56A	206	JESD22A-113	Performed on surface mount devices (SMDs) prior to TC,AC, H3TRB,HAST & IOL,PTC stresses only.	0% failure at MSL Level 1
	High Temperature Reverse Bias (HTRB)	TPSMC56A	77	JESD22-A108	150°C, 1000hrs	0% failure at 1000 hours
	Temperature Cycling (TC)	TPSMC56A	77	JESD22-A104	-55℃&150℃ (air to air),1000 cycles	0% failure at 1000 cycles
	High-temperature High-humidity Reverse Bias(H3TRB)	TPSMC56A	77	JESD22-A101	85℃, 85%RH, 80%VR,1000 hrs	0% failure at 1000 hours
	Highly Accelerated Stress Test (HAST)	TPSMC56A	77	JESD22-A101	130℃, 85%RH 80%VR, 96hrs	0% failure at 96 hours
	Resistance to solder heat(RSH)	TPSMC56A	30	JESD22-B106 JESD22-A111	260°C(+5,-0),10sec	0% failure after RSH
	Solderability(SD)	TPSMC56A	10	J-STD-002	235℃±5℃, 3sec	0% failure after Solderability
	Moisture Soak Level (MSL)	TPSMC56A	22	JESD020D	85℃, 85%RH,168hRS	0% failure at MSL Level 1
	Destructive Physical Analysis(DPA)	TPSMC56A	2	AEC-Q101-004 Section	Completed H3TRB or HAST, and TC.	100% meet published spec.



#### 3. Conclusion

According to the above qualification test results, Semicon Champion concluded that TPSMB product series passed the all the AEC-Q101 Reliability Test at WTC Lab, which is ready to start mass production.

Below is the TPSMC Series Part Number list covered by this report:

TPSMC12A, TPSMC12CA, TPSMC13A, TPSMC13CA, TPSMC15A, TPSMC15CA, TPSMC16A, TPSMC16CA, TPSMC18A, TPSMC18CA, TPSMC20A, TPSMC20CA, TPSMC22A, TPSMC22CA, TPSMC24A, TPSMC24CA, TPSMC27A, TPSMC27CA, TPSMC30A, TPSMC30CA, TPSMC33A, TPSMC33CA, TPSMC36A, TPSMC36CA, TPSMC39A, TPSMC39CA, TPSMC43A, TPSMC43CA, TPSMC47A, TPSMC47CA, TPSMC51A, TPSMC51CA, TPSMC56A, TPSMC56CA, TPSMC62A, TPSMC62A, TPSMC68A, TPSMC68CA, TPSMC75A, TPSMC75CA, TPSMC82A, TPSMC82CA, TPSMC91A, TPSMC91CA, TPSMC100A, TPSMC100CA, TPSMC110A, TPSMC110CA, TPSMC120A, TPSMC120CA, TPSMC130A, TPSMC130CA, TPSMC140A, TPSMC140CA, TPSMC150A, TPSMC150CA, TPSMC160A, TPSMC160CA, TPSMC170A, TPSMC170CA, TPSMC180A, TPSMC180CA, TPSMC200A, TPSMC200CA, TPSMC220A, TPSMC220CA, TPSMC250A, TPSMC250CA,

#### 4. MTBF Calculation

Temp °C	% FR/khrs	MTBF (K)	FITS
30	0.0000228	4380864	0.228
55	0.0004225	236700	4.225
85	0.0081844	12218	81.844
100	0.0301256	3319	301.256
125	0.2125123	471	2125.123
150	1.189988	84	11899.880

Estimate of Failure Rate, MTBF, FITS for a Given Operation Temperature (See note)

Note: The Mean-Time-Between-Failure (MTBF) in hours and the percent failure rate per 1000 hours (%FR/khr) are computed at a 60% confidence level using the chi square method and the Arrhenius derating model for various junction operating temperatures. For the calculations, a value of 1 eV was used for the activation energy.



## 5. Appendix A – Pre & Post Test Electrical Performance Distribution

• Based on our 1 qual lots data, our actual VZ drift is within + 10% (AEC 20%), IR leakage drift is within + 50% (AEC 5 times for normal leakage and 10 times for moisture leakage).

• AEC required :

Parts not remaining within  $\pm$  20% of the initial reading of each test (with the exception of leakage limits which are not to exceed 10 times the initial value for moisture tests and 5 times leakage the initial value for all others) after completion of environmental testing. Parts exceeding these guidelines must be justified by the supplier and approved by the user. For leakages below 100nA, tester accuracy may prevent a post stress analysis to initial reading





